TEST REPORT



Miniature Waterproof 4 types WtB Connector

1. Purpose:

This is qualification test. The purpose of this test is to evaluate the performance of miniature waterproof 4 types WtB connector. Testing was performed on below products to determine it compliance with the requirements of product specification.

2. Scope:

This is test report for miniature waterproof 4 types WtB connector. Testing was performed at TE Connectivity Shanghai Electrical Components Test Laboratory between Aug.02th, 2017 and Sep.19th, 2017.

3. Conclusion:

The product met the electrical, mechanical, and environmental performance requirements of TE product specification

4. Test samples:

Samples were taken randomly from current production. The following part numbers were used for test:

Description	Product Part No.
Vertical SMT Connector	*-2834235-*
R/A SMT Connector	*-2834236-*
Vertical DIP Connector	*-2834237-*
R/A DIP Connector	*-2834238-*

5. Test Method

5.1 Examination of Product

Visual, dimensional and functional per applicable inspection plan.

Requirements: Meets requirements of product drawing

Test Method: In accordance with EIA-364-18

5.2 Contact Resistance

Subject the specimen to maximum allowed rating current and measure the contact resistance.

Requirements: $20m\Omega$ Max. Test Method: EIA-364-06

5.3 Temperature Rise

Measured at maximum rated current with series all contacts. (Matched with 2834182-*)

Current: 5.5A for 18-20AWG

4A for 22AWG

Requirement: Temperature rise should be 30°C Max.

Test method: EIA-364-70

Rev. A 1 of 6



5.4 Vibration, Random

Subject mated specimens to 3.10G's rms between 20~500HZ. Fifteen minutes in each of 3 mutually perpendicular planes.

Requirements: Discontinuity max 1 μ s

Test method: EIA-364-28, Test Condition VII, Condition D

5.5 Mechanical shock

Subject mated specimens to 30 G's half-sine shock pulses of 11 milliseconds duration. Three shocks in each direction applied along 3 mutually perpendicular planes, 18 total shocks.

Requirements: Discontinuity max 1 $\,\mu$ s Test method: EIA-364-27, Condition H

5.6 Housing lock strength

Determine housing lock strength at a maximum rate of 12.7 mm [.5 in] per minute.

Requirements: 30N Min. Test method: EIA-364-98.

5.7 Mating Force

Measure force necessary to mate specimens at a max rate of 12.7mm per minute.

Requirements: 40N Max
Test method: EIA-364-13.

5.8 Unmating force(Without latch)

Measure force necessary to unmated specimens at a max rate of 12.7mm per minute.

Requirements: 10N Max. Test method: EIA-364-13

5.9 Contact retention force

Measure force necessary to unmated specimens at a max rate of 12.7mm per minute.

Requirements: 14N Min. Test method: EIA-364-13

5.10 Thermal Shock

Subject specimens to 25 cycles between -40 and 105°C with 30 minute dwells at temperature extremes and 1 minute transition between temperatures.

Requirements: Contact resistance $20m\Omega$ Max. Test method: EIA-364-32, Test Condition VII

5.11 Humidity (cycling Temperature)

Subject specimens to 10 cycles (10 days) between 25 °C and 65 °C at 80 to 100% RH.

Rev. A 2 of 6

connectivity TEST REPORT 501-137266

Requirements: Contact resistance 25mΩ Max.

Test method: EIA-364-31, Method III

5.12 Temperature life

Subject mated specimens to 105 °C for 648 hours.

Requirements: LLCR $20m\Omega$ Max. Test method: EIA-364-17, Method A

5.13 Withstanding voltage

Unmated connector with 1500 V AC between adjacent contacts for 1 min

Requirements: No breakdown or flashover

Test method: EIA-364-20, Condition I

5.14 Insulation resistance

Unmated connector with 500 V DC between adjacent contacts for 1 min.

Requirements: 1000 M Ω Min

Test method: EIA-364-21

5.15 Durability

Mating and unmating specimens for 30 cycles at a max rate of 500 cycles per hour.

Requirement: No mechanical damage; No change to performance; Contact resistance: 20mΩ Max;

Test method: EIA-364-09

5.16 Ingress protection.

Waterproof IPX7 Test.

Requirements: No physical damage, and meet requirements of additional tests specified in Product Qualification

Test Sequence

Test method: IEC 60529, IPX7.

5.17 Use aging.

Subject specimens to $113 \pm 5\%$ for 168 hours.

Requirements: No physical damage, and meet requirements of additional tests specified in Product Qualification

Test Sequence

Test method: UL 486D, Sections 9.4.1.1(a).

6. Unless otherwise stated, the following environmental conditions prevailed during testing:

Temperature:5℃ to 35℃ Relative Humidity: 45 % to 80%

7. Test Sequence

Rev. A 3 of 6

TEST REPORT 501-137266

commountry		\ 1				
Test group	a	b	c	d	e	f
Examination of product	1,7	1,7	1	1	1,5	1,5
Contact resistance	2,6	2,6				
Insulation resistance			2,6			
Withstanding Voltage			3,7			
Current rating		3				
Contact retention force				2		
Random vibration	4					
Mechanical shock	5					
Durability	3					3
Mating force						2
Unmating force(without latch)						4
Housing lock strength				3		
Thermal shock			4			
Humidity -temperature cycling		4	5			
Temperature life		5				
Ingress protection					2,4	
Use aging					3	
Sample size	5(a)	5(c)	5(a)	5(b)	5(b)	5(b)

NOTE

- a. 5 sets of each type for default wire size: 20AWG.
- b. 5 sets for 2834237-* only
- c. 5 sets for 20AWG, 5 sets for 22AWG.

8. Test Result

Gro	Test Item	N	Condition	Test Result			Requirement	Judg
up				Max	Min	Ave	Requirement	ment
Α	Examination of Product	20	Initial	No physical damage occurred			No abnormalities	Pass
	Contact resistance(*-2834235-*)	5	Initial	5.25	4.28	4.75	<20mΩ	Pass
	Contact resistance(*-2834236-*)	5	Initial	5.32	4.78	5.07	<20mΩ	Pass
	Contact resistance(*-2834237-*)	5	Initial	4.88	4.05	4.46	<20mΩ	Pass
	Contact resistance(*-2834238-*)	5	Initial	5.62	4.82	5.20	<20mΩ	Pass
	Durability	20	Final	No physical damage occurred			No abnormalities	Pass
	Random Vibration	20	Final	No discontinuities of 1 microsecond or longer duration occurred			No abnormalities	Pass
	Mechanical Shock	20	Final	No discontinuities of 1 microsecond or longer duration occurred			No abnormalities	Pass
	Contact resistance(*-2834235-*)	5	Final	8.59	4.09	5.80	<20mΩ	Pass

Rev. A 4 of 6



TEST REPORT 501-137266 Contact resistance(*-2834236-*) 4.62 6.06 5.16 <20m Ω **Pass** Final Contact resistance(*-2834237-*) 5 Final 5.52 4.51 4.96 $<20m\Omega$ **Pass** Contact resistance(*-2834238-*) 5 Final 5.96 5.07 5.39 $<20m\Omega$ **Pass** No **Examination of Product** 20 Final No physical damage occurred **Pass** abnormalities **Examination of Product** 20 Initial No physical damage occurred **Pass** abnormalities Contact resistance (*-2834235-*) 5 Initial 5.55 4.30 5.05 $<20m\Omega$ **Pass** Initial Contact resistance (*-2834236-*) 5 5.30 4.18 4.68 $<20 \text{m}\Omega$ **Pass** Initial Contact resistance (*-2834237-*) 5 5.20 4.10 4.91 $<20m\Omega$ **Pass** Initial Contact resistance (*-2834238-*) 5 4.80 5.10 $<20m\Omega$ **Pass** 5.35 Current rating (20AWG/ 5.5A) 5 Initial 28.80 18.53 23.73 △30°C Max **Pass** Current rating (22AWG/4A) 5 Initial 24.10 12.52 18.54 △30°C Max **Pass** В No Humidity (cycling Temperature) 20 Final No physical damage occurred abnormalities **Pass** No Temperature life 20 Final No visual change found **Pass** abnormalities Contact resistance (*-2834235-*) 5 Final 7.69 4.15 5.55 $<20m\Omega$ **Pass** Final Contact resistance (*-2834236-*) 5 7.12 4.25 5.31 $<20m\Omega$ **Pass** Final Contact resistance (*-2834237-*) 5 6.52 4.21 5.66 $<20m\Omega$ **Pass** Final Contact resistance (*-2834238-*) 5 6.96 5.25 5.60 $<20m\Omega$ **Pass** No 20 **Examination of Product** Final No physical damage occurred **Pass** abnormalities No **Examination of Product** 20 Initial Pass No physical damage occurred abnormalities Insulation resistance (unit:10¹¹Ω) 5 Initial 4.35 2.28 3.00 1000MΩ Min **Pass** (*-2834235-*) Insulation resistance (unit:10¹¹Ω) 5 Initial 2.71 3.52 1.82 1000MΩ Min **Pass** (*-2834236-*) Insulation resistance (unit:10¹¹Ω) 5 Initial 7.40 0.99 4.18 $1000M\Omega$ Min **Pass (*-2834237-*)** Insulation resistance (unit:10¹¹Ω) 5 2.25 Initial 3.11 1.31 1000MΩ Min **Pass** (*-2834238-*) No Withstanding Voltage 20 Final No Breakdown **Pass** abnormalities No Thermal shock 20 Final No visual change found **Pass** abnormalities C No Humidity (cycling Temperature) 20 Final No physical damage occurred abnormalities **Pass** Insulation resistance (unit:10¹¹Ω) **Pass** 5 Final 3.59 2.18 2.95 1000MΩ Min (*-2834235-*) Insulation resistance (unit:10¹¹Ω) 5 2.32 3.20 $1000M\Omega$ Min **Pass** Final 4.55 (*-2834236-*) Insulation resistance (unit:10¹¹Ω) 5 5.45 1.29 $1000M\Omega$ Min Final 3.85 **Pass** (*-2834237-*) Insulation resistance (unit:10¹¹Ω) 5 Final 4.69 2.30 3.51 $1000M\Omega$ Min **Pass** (*-2834238-*) No Withstanding Voltage 20 Final No Breakdown **Pass** abnormalities No **Examination of Product** 20 Final No physical damage occurred **Pass** abnormalities No No physical damage occurred **Examination of Product** 5 Initial **Pass** abnormalities

Rev. A 5 of 6



501-137266 **TEST REPORT** D Contact retention force 5 Final 99.8 55.2 78.2 >14N Pass 5 Final 173.69 179.43 >30N Housing lock strength 191.31 Pass No **Examination of Product** 5 Final No physical damage occurred Pass abnormalities No **Examination of Product** 5 Initial No physical damage occurred Pass abnormalities No Ingress protection 5 Final No water ingress **Pass** abnormalities Final 5 No physical damage occurred Pass Use aging abnormalities No Ε Ingress protection 5 Final No water ingress Pass abnormalities No **Examination of Product** 5 Final No physical damage occurred Pass abnormalities No **Examination of Product** 5 Initial Nophysical damage occurred Pass abnormalities F 14.50 5 18.41 16.05 40N Max Mating force Final **Pass** Durability 5 Final No physical damage occurred Pass abnormalities Unmating force (without latch) 5 Final 5.88 3.65 4.70 10N Max **Pass** No **Examination of Product** 5 Final Pass No physical damage occurred abnormalities

END

Rev. A 6 of 6